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	94	algorithm adj "42"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:15
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-	0	(algorithm adj "42").ti.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:15
-	174	elicit.ti.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:30
-	3	elicit.ti. and algorithm\$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:31
-	9788	elicit and algorithm\$2	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/06/09 17:34
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Madhavji, N.H.; Holtje, D.; Won Kook Hong; Bruckhaus, T.;
Software Process, 1994. 'Applying the Software Process', Proceedings., Third International Conference on the , 10-11 Oct. 1994
Pages:111 - 122

[\[Abstract\]](#) [\[PDF Full-Text \(960 KB\)\]](#) **IEEE CNF****2 Transition interval estimation to elicit membership functions in fuzzy evaluation models of animal production systems**

Cornelissen, A.M.G.; Kaymak, U.; van den Berg, J.; Koops, W.J.;
Fuzzy Systems, 2003. FUZZ '03. The 12th IEEE International Conference on , Volume: 2 , 25-28 May 2003
Pages:1200 - 1205 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(503 KB\)\]](#) **IEEE CNF****3 Causal knowledge elicitation based on elicitation failures**

Mussi, S.;
Knowledge and Data Engineering, IEEE Transactions on , Volume: 7 , Issue: 5 , Oct. 1995
Pages:725 - 739

[\[Abstract\]](#) [\[PDF Full-Text \(1572 KB\)\]](#) **IEEE JNL****4 Guided expert self-elicitation: generalizing captured expertise**

Shephard, G.G.;
System Sciences, 1991. Proceedings of the Twenty-Fourth Annual Hawaii International Conference on , Volume: iii , 8-11 Jan. 1991
Pages:235 - 243 vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(744 KB\)\]](#) [IEEE CNF](#)

5 Requirements elicitation with indirect knowledge elicitation technique comparison of three methods

Hudlicka, E.;

Requirements Engineering, 1996., Proceedings of the Second International Conference on , 15-18 April 1996

Pages:4 - 11

[\[Abstract\]](#) [\[PDF Full-Text \(804 KB\)\]](#) [IEEE CNF](#)

6 Discourse analysis of requirements and knowledge elicitation interview

Alvarez, R.;

System Sciences, 2002. HICSS. Proceedings of the 35th Annual Hawaii International Conference on , 7-10 Jan. 2002

Pages:10 pp.

[\[Abstract\]](#) [\[PDF Full-Text \(419 KB\)\]](#) [IEEE CNF](#)

7 A method for evaluating elicitation schemes for probabilistic models

Wang, H.; Dash, D.; Druzdzel, M.J.;

Systems, Man and Cybernetics, Part B, IEEE Transactions on , Volume: 32 , Issue: 1 , Feb. 2002

Pages:38 - 43

[\[Abstract\]](#) [\[PDF Full-Text \(131 KB\)\]](#) [IEEE JNL](#)

8 Knowledge elicitation for authoring patent claims

Sheremeteva, S.; Nirenburg, S.;

Computer , Volume: 29 , Issue: 7 , July 1996

Pages:57 - 63

[\[Abstract\]](#) [\[PDF Full-Text \(1804 KB\)\]](#) [IEEE JNL](#)

9 An approach to software requirements elicitation using precepts from activity theory

Martins, L.E.G.; Daltrini, B.M.;

Automated Software Engineering, 1999. 14th IEEE International Conference on , 12-15 Oct. 1999

Pages:15 - 23

[\[Abstract\]](#) [\[PDF Full-Text \(52 KB\)\]](#) [IEEE CNF](#)

10 Issue-based requirements elicitation and description

Wing Lam;

Software Engineering and AI (Artificial Intelligence), IEE Colloquium on (Digest No.087) , 10 Apr 1992

Pages:5/1 - 5/3

[\[Abstract\]](#) [\[PDF Full-Text \(132 KB\)\]](#) [IEEE CNF](#)

11 Decision support system class for R&D planning

Larichev, O.I.; Moshkovich, H.M.;
Expert Planning Systems, 1991., First International Conference on , 27-29 Ju
1990
Pages:227 - 232

[\[Abstract\]](#) [\[PDF Full-Text \(416 KB\)\]](#) [IEE CNF](#)

**12 Schema-based knowledge elicitation for planning and situation
assessment aids**

Noble, D.F.;
Systems, Man and Cybernetics, IEEE Transactions on , Volume: 19 , Issue:
3 , May-June 1989
Pages:473 - 482

[\[Abstract\]](#) [\[PDF Full-Text \(988 KB\)\]](#) [IEEE JNL](#)

13 Viewpoints for requirements elicitation: a practical approach

Sommerville, I.; Sawyer, P.; Viller, S.;
Requirements Engineering, 1998. Proceedings. 1998 Third International Conf
on , 6-10 April 1998
Pages:74 - 81

[\[Abstract\]](#) [\[PDF Full-Text \(72 KB\)\]](#) [IEEE CNF](#)

**14 RECAP: a requirements elicitation, capture and analysis process
prototype tool for large complex systems**

Edwards, M.L.; Flanzer, M.; Terry, M.; Landa, J.;
Engineering of Complex Computer Systems, 1995. Held jointly with 5th CSES
3rd IEEE RTAW and 20th IFAC/IFIP WRTP, Proceedings., First IEEE Internatio
Conference on , 6-10 Nov. 1995
Pages:278 - 281

[\[Abstract\]](#) [\[PDF Full-Text \(316 KB\)\]](#) [IEEE CNF](#)

15 The elicitation of business planning knowledge

Fowell, S.;
Knowledge Engineering, IEE Colloquium on , 15 May 1990
Pages:7/1 - 7/4

[\[Abstract\]](#) [\[PDF Full-Text \(208 KB\)\]](#) [IEE CNF](#)

[1](#) [2](#) [3](#) [4](#) [5](#) [6](#) [7](#) [8](#) [9](#) [10](#) [11](#) [12](#) [13](#) [14](#) [15](#) [16](#) [17](#) [18](#) [19](#) [20](#) [21](#) [22](#) [23](#)
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Ahmed, M.M.; Ahmed, H.; Ladbrooke, P.H.;
Electron Devices, IEEE Transactions on, Volume: 44, Issue: 3, March 1997
Pages:360 - 363

[\[Abstract\]](#) [\[PDF Full-Text \(112 KB\)\]](#) **IEEE JNL****2 Computing ferrite core losses at high frequency by finite elements method including temperature influence**

Ahmed, B.; Ahmed, J.; Guy, G.;
Magnetics, IEEE Transactions on, Volume: 30, Issue: 5, Sep 1994
Pages:3733 - 3736

[\[Abstract\]](#) [\[PDF Full-Text \(204 KB\)\]](#) **IEEE JNL****3 3D reconstruction of the human jaw from a sequence of images**

Ahmed, M.; Yamany, S.; Hemayed, E.; Ahmed, S.; Roberts, S.; Farag, A.;
Computer Vision and Pattern Recognition, 1997. Proceedings., 1997 IEEE Computer Society Conference on, 17-19 June 1997
Pages:646 - 653

[\[Abstract\]](#) [\[PDF Full-Text \(1076 KB\)\]](#) **IEEE CNF****4 A high performance 0.25 μm logic technology optimized for 1.8 V operation**

Bohr, M.; Ahmed, S.S.; Ahmed, S.U.; Bost, M.; Ghani, T.; Greason, J.; Hains R.; Jan, C.; Packan, P.; Sivakumar, S.; Thompson, S.; Tsai, J.; Yang, S.;
Electron Devices Meeting, 1996., International, 8-11 Dec. 1996
Pages:847 - 850

[\[Abstract\]](#) [\[PDF Full-Text \(348 KB\)\]](#) [IEEE CNF](#)

5 Estimation of intrinsic small signal parameters of a GaAs MESFET from DC measurements

Ahmed, M.M.; Ahmed, N.; Chaudhary, K.S.; Iqbal, M.F.;

Multi Topic Conference, 2001. IEEE INMIC 2001. Technology for the 21st Century Proceedings. IEEE International, 28-30 Dec. 2001

Pages:97 - 103

[\[Abstract\]](#) [\[PDF Full-Text \(583 KB\)\]](#) [IEEE CNF](#)

6 Fuzzy controllers design using space-filling curves

Elshafei-Ahmed, M.; Ahmed, M.S.;

American Control Conference, 1998. Proceedings of the 1998, Volume: 3, 2-5 June 1998

Pages:1855 - 1859 vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(368 KB\)\]](#) [IEEE CNF](#)

7 Design and modeling of a slotless and homopolar axial-field synchronous machine for a flywheel accumulator

Bernard, N.; Ahmed, H.B.; Multon, B.;

Industry Applications, IEEE Transactions on, Volume: 40, Issue: 3, May-June 2004

Pages:755 - 762

[\[Abstract\]](#) [\[PDF Full-Text \(544 KB\)\]](#) [IEEE JNL](#)

8 A novel method for ATC computations in a large-scale power system

Khairuddin, A.B.; Ahmed, S.S.; Mustafa, M.W.; Zin, A.A.M.; Ahmad, H.;

Power Systems, IEEE Transactions on, Volume: 19, Issue: 2, May 2004

Pages:1150 - 1158

[\[Abstract\]](#) [\[PDF Full-Text \(320 KB\)\]](#) [IEEE JNL](#)

9 The effect of LUT and cluster size on deep-submicron FPGA performance and density

Ahmed, E.; Rose, J.;

Very Large Scale Integration (VLSI) Systems, IEEE Transactions on, Volume: 12, Issue: 3, March 2004

Pages:288 - 298

[\[Abstract\]](#) [\[PDF Full-Text \(568 KB\)\]](#) [IEEE JNL](#)

10 The evaluation of performance parameters of MOSFETs with alternating gate dielectrics

Ahmed, K.Z.; Kraus, P.A.; Olsen, C.; Nouri, F.;

Electron Devices, IEEE Transactions on, Volume: 50, Issue: 12, Dec. 2003

Pages:2564 - 2567

[\[Abstract\]](#) [\[PDF Full-Text \(337 KB\)\]](#) [IEEE JNL](#)

11 Time-dependent measurement of the mode-competition phenomenon among longitudinal modes in long-wavelength lasers
Yamada, M.; Ishimori, W.; Sakaguchi, H.; Ahmed, M.;
Quantum Electronics, IEEE Journal of, Volume: 39, Issue: 12, Dec. 2003
Pages:1548 - 1554

[\[Abstract\]](#) [\[PDF Full-Text \(426 KB\)\]](#) [IEEE JNL](#)

12 Data Structure for Association Rule Mining: T-Trees and P-Trees
Leng, P.; Coenen, F.; Ahmed, S.;
Knowledge and Data Engineering, IEEE Transactions on, Volume: 16, Issue: 6, June 2004
Pages:774 - 778

[\[Abstract\]](#) [\[PDF Full-Text \(984 KB\)\]](#) [IEEE JNL](#)

13 Testing SoC Interconnects for Signal Integrity Using Extended JTAT Architecture
Tehranipour, M.H.; Ahmed, N.; Nourani, M.;
Computer-Aided Design of Integrated Circuits and Systems, IEEE Transaction on, Volume: 23, Issue: 5, May 2004
Pages:800 - 811

[\[Abstract\]](#) [\[PDF Full-Text \(672 KB\)\]](#) [IEEE JNL](#)

14 Book reviews - FAST TRANSFORMS, algorithms, analyses, applications
Ahmed, N.;
ASSP Magazine, IEEE [see also IEEE Signal Processing Magazine], Volume: 1, Issue: 2, Apr 1984
Pages:39 - 39

[\[Abstract\]](#) [\[PDF Full-Text \(95 KB\)\]](#) [IEEE JNL](#)

15 Position spectrum considerations
Ahmed, N.; Schultz, R.;
Audio and Electroacoustics, IEEE Transactions on, Volume: 19, Issue: 4, Dec 1971
Pages:326 - 327

[\[Abstract\]](#) [\[PDF Full-Text \(208 KB\)\]](#) [IEEE JNL](#)

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Electron Devices Meeting, 1996., International , 8-11 Dec. 1996
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Khairuddin, A.B.; Ahmed, S.S.; Mustafa, M.W.; Zin, A.A.M.; Ahmad, H.;
Power Systems, IEEE Transactions on ,Volume: 19 , Issue: 2 , May 2004
Pages:1150 - 1158

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Leng, P.; Coenen, F.; Ahmed, S.;
Knowledge and Data Engineering, IEEE Transactions on ,Volume: 16 , Issue: 6 , June 2004
Pages:774 - 778

[\[Abstract\]](#) [\[PDF Full-Text \(984KB\)\]](#) **IEEE JNL**

4 Discharge dynamics of the magnetically confined ion gas laser

Ahmed, S.; Faith, T., Jr.;
Quantum Electronics, IEEE Journal of ,Volume: 2 , Issue: 4 , Apr 1966
Pages:101 - 101

[\[Abstract\]](#) [\[PDF Full-Text \(288KB\)\]](#) **IEEE JNL**

5 RF inductively excited ion laser with aperture- magnetic confinement

Ahmed, S.;
Quantum Electronics, IEEE Journal of ,Volume: 4 , Issue: 5 , May 1968
Pages:358 - 359

[\[Abstract\]](#) [\[PDF Full-Text \(400KB\)\]](#) [IEEE JNL](#)

6 Saturation and discharge studies in the He-Cd laser

Giallorenzi, T.; Ahmed, S.;

Quantum Electronics, IEEE Journal of ,Volume: 7 , Issue: 1 , Jan 1971

Pages:11 - 17

[\[Abstract\]](#) [\[PDF Full-Text \(832KB\)\]](#) [IEEE JNL](#)

7 Optical and discharge excitation of organic dye vapors

Ahmed, S.; Pappalardo, R.;

Quantum Electronics, IEEE Journal of ,Volume: 8 , Issue: 6 , Jun 1972

Pages:525 - 525

[\[Abstract\]](#) [\[PDF Full-Text \(432KB\)\]](#) [IEEE JNL](#)

8 RF inductively excited ion laser with aperture-magnetic confinement

Ahmed, S.; Campillo, A.; Cody, R.;

Quantum Electronics, IEEE Journal of ,Volume: 5 , Issue: 6 , Jun 1969

Pages:267 - 271

[\[Abstract\]](#) [\[PDF Full-Text \(600KB\)\]](#) [IEEE JNL](#)

9 Energy transfer processes in organic dye laser mixtures

Ahmed, S.; Gergely, J.; Infante, D.;

Quantum Electronics, IEEE Journal of ,Volume: 11 , Issue: 9 , Sep 1975

Pages:824 - 825

[\[Abstract\]](#) [\[PDF Full-Text \(312KB\)\]](#) [IEEE JNL](#)

10 Magnetic properties and morphology of block copolymer templated ferrimagnetic CoFe₂O₄ nanoparticles

Ahmed, S.R.; Ogale, S.B.; Kofinas, P.;

Magnetics, IEEE Transactions on ,Volume: 39 , Issue: 5 , Sept. 2003

Pages:2198 - 2200

[\[Abstract\]](#) [\[PDF Full-Text \(353KB\)\]](#) [IEEE JNL](#)

11 Selection criteria of induction machines for speed-sensorless drive applications

Nandi, S.; Ahmed, S.; Toliat, H.A.; Bharadwaj, R.M.;

Industry Applications, IEEE Transactions on ,Volume: 39 , Issue: 3 , May-Jur 2003

Pages:704 - 712

[\[Abstract\]](#) [\[PDF Full-Text \(596KB\)\]](#) [IEEE JNL](#)

12 Modeling of an EMP simulator using a 3-D FDTD code

Ahmed, S.; Sharma, D.; Chaturvedi, S.;

Plasma Science, IEEE Transactions on ,Volume: 31 , Issue: 2 , April 2003

Pages:207 - 215

[\[Abstract\]](#) [\[PDF Full-Text \(467KB\)\]](#) [IEEE JNL](#)

13 A scheme for controlled islanding to prevent subsequent blackout
Ahmed, S.S.; Sarker, N.C.; Khairuddin, A.B.; Ghani, M.R.B.A.; Ahmad, H.;
Power Systems, IEEE Transactions on ,Volume: 18 , Issue: 1 , Feb. 2003
Pages:136 - 143

[\[Abstract\]](#) [\[PDF Full-Text \(552KB\)\]](#) [IEEE JNL](#)

14 Potential benefits of using distributed parameter model for transmission lines in power system analysis
Ahmed, S.S.; Rajaratnam, M.; Ahmad, H.; Sidik, M.A.B.;
Power Engineering Review, IEEE ,Volume: 22 , Issue: 10 , Oct. 2002
Pages:53 - 56

[\[Abstract\]](#) [\[PDF Full-Text \(376KB\)\]](#) [IEEE JNL](#)

15 Detection of rotor slot and other eccentricity related harmonics in three phase induction motor with different rotor cages
Nandi, S.; Ahmed, S.; Toliyat, H.A.;
Energy Conversion, IEEE Transactions on ,Volume: 16 , Issue: 3 , Sept. 2001
Pages:253 - 260

[\[Abstract\]](#) [\[PDF Full-Text \(196KB\)\]](#) [IEEE JNL](#)

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[Abstract] [PDF Full-Text (288KB)] IEEE JNL

6 Overhead infrared sensor for monitoring vehicular traffic

Hussain, T.M.; Saadawi, T.N.; Ahmed, S.A.;
Vehicular Technology, IEEE Transactions on ,Volume: 42 , Issue: 4 , Nov. 19
Pages:477 - 483

[\[Abstract\]](#) [\[PDF Full-Text \(512KB\)\]](#) [IEEE JNL](#)

7 Simulation of 12.5 Gb/s lightwave optical time-division multiplexer using semiconductor optical amplifiers as external modulators

Ali, M.A.; Elrefaie, A.F.; Ahmed, S.A.;
Photonics Technology Letters, IEEE , Volume: 4 , Issue: 3 , March 1992
Pages:280 - 283

[Abstract] [PDF Full-Text (352KB)] IEEE JNL

8 A comparison of methods to estimate particle size distribution parameters and associated errors from multiwavelength optical coefficients

Herman, B.R.; Gross, B.M.; Moshary, F.; Ahmed, S.A.;
Lasers and Electro-Optics, 2000. (CLEO 2000). Conference on , 7-12 May 2000
Pages:139 - 140

[Abstract] [PDF Full-Text (172KB)] **IEEE CNF**

9 Destructive multiphoton interference in optical coherent transients

Moshary, F.; Gross, B.M.; Zhang, Y.; Ahmed, S.A.; Hartmann, S.R.;
Quantum Electronics and Laser Science Conference, 2000. (QELS 2000). Tech
Digest , 7-12 May 2000
Pages:250 - 251

[Abstract] [PDF Full-Text (168KB)] IEEE CNF

10 Steady flow measurements in a vaneless diffuser

Abidogun, K.B.; Ahmed, S.A.;
Energy Conversion Engineering Conference and Exhibit, 2000. (IECEC) 35th
Intersociety ,Volume: 2 , 24-28 July 2000
Pages:1287 - 1294 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(404KB\)\]](#) [\[IEEE CNF\]](#)

11 Mobile ip based mobility management for 3g wireless networks

Zaman Bajwa, W.U.; Ahmed, S.A.; Zulfiqar, S.; Abbas, A.; Qayyum, A.;
Students Conference, 2002. ISCON '02. Proceedings. IEEE ,Volume: 2 , Aug.
17, 2002
Pages:10 - 10

[Abstract] [PDF Full-Text (181KB)] IEEE CNF

12 Active and passive infrared sensors for vehicular traffic control

Ahmed, S.A.; Hussain, T.M.; Saadawi, T.N.;

Vehicular Technology Conference, 1994 IEEE 44th , 8-10 June 1994
Pages:1393 - 1397 vol.2

[Abstract] [PDF Full-Text (372KB)] IEEE CNF

13 ATM multimedia traffic prediction using neural networks

Tarraf, A.A.; Habib, I.W.; Saadawi, T.N.; Ahmed, S.A.;
Global Data Networking, 1993. Proceedings , 12-15 Dec. 1993
Pages:77 - 84

[\[Abstract\]](#) [\[PDF Full-Text \(592KB\)\]](#) [IEEE CNF](#)

14 A completely pipelined regular array processor implementation of RITE algorithm

DeBrunner, L.S.; Ahmed, S.A.; DeBrunner, V.E.; Ballew, W.D.;
Signals, Systems and Computers, 1993. 1993 Conference Record of The Twei
Seventh Asilomar Conference on , 1-3 Nov. 1993
Pages:771 - 775 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(320KB\)\]](#) [IEEE CNF](#)

15 Complex system identification methods for fast echo canceler initialization

Ahmed, S.A.; Cruz, J.R.;
Acoustics, Speech, and Signal Processing, 1992. ICASSP-92., 1992 IEEE
International Conference on ,Volume: 4 , 23-26 March 1992
Pages:525 - 528 vol.4

[Abstract] [PDF Full-Text (320KB)] **IEEE CNF**

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production flexible systems command

Ahmed, S.B.; Moalla, M.; Esteban, P.; Courvoisier, M.;
Systems, Man and Cybernetics, 1993. 'Systems Engineering in the Service of
Humans', Conference Proceedings., International Conference on , 17-20 Oct.
Pages:30 - 35 vol.1

[Abstract] [PDF Full-Text (584KB)] IEEE CNF

6 Structuring, Specification And Validation Of The Control Part In Fle Production Systems

Ahmed, S.B.; Esteban, P.; Courvoisier, M.; Moalla, M.;
Emerging Technologies and Factory Automation, 1992. IEEE International
Workshop on , August 11-14, 1992
Pages:56 - 60

[Abstract] [PDF Full-Text (644KB)] **IEEE CNF**

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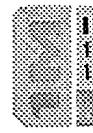


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1 Design of IIR filters with simultaneous amplitude and group-delay characteristics using genetic algorithm
Abo-Zahhad, M.; Ahmed, S.M.;
Electronics, Circuits and Systems, 2003. ICECS 2003. Proceedings of the 2003 IEEE International Conference on ,Volume: 3 , 14-17 Dec. 2003
Pages:1148 - 1151 Vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(1450KB\)\]](#) [IEEE CNF](#)

2 Electrocardiogram data compression algorithm based on the linear prediction of the wavelet coefficients
Abo-Zahhad, M.; Ahmed, S.M.; Al-Shrouf, A.;
Electronics, Circuits and Systems, 2000. ICECS 2000. The 7th IEEE International Conference on ,Volume: 1 , 17-20 Dec. 2000
Pages:599 - 603 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(428KB\)\]](#) [IEEE CNF](#)

3 Filter designer: a complete design and synthesis program for lumped wave-digital, FIR and IIR filters
Abo-Zahhad, M.; Ahmed, S.M.;
Radio Science Conference, 1996. NRSC '96., Thirteenth National , 19-21 March 1996
Pages:425 - 439

[\[Abstract\]](#) [\[PDF Full-Text \(804KB\)\]](#) [IEEE CNF](#)

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Ahmed, S.R.; Ogale, S.B.; Kofinas, P.;
Magnetics, IEEE Transactions on, Volume: 39, Issue: 5, Sept. 2003
Pages:2198 - 2200

[\[Abstract\]](#) [\[PDF Full-Text \(353KB\)\]](#) **IEEE JNL****2 Applications of data mining in retail business**

Ahmed, S.R.;
Information Technology: Coding and Computing, 2004. Proceedings. ITCC 2004. International Conference on, Volume: 2, April 5-7, 2004
Pages:455 - 459

[\[Abstract\]](#) [\[PDF Full-Text \(1309KB\)\]](#) **IEEE CNF****3 Load management services in post-contingency control**

Strbac, G.; Ahmed, S.R.M.; Kirschen, D.;
Power System Control and Management, Fourth International Conference on (Publ. No. 421), 16-18 April 1996
Pages:76 - 81

[\[Abstract\]](#) [\[PDF Full-Text \(440KB\)\]](#) **IEE CNF**

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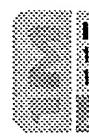
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1 A novel method for ATC computations in a large-scale power system
Khairuddin, A.B.; Ahmed, S.S.; Mustafa, M.W.; Zin, A.A.M.; Ahmad, H.
Power Systems, IEEE Transactions on , Volume: 19 , Issue: 2 , May 2004
Pages:1150 - 1158

[\[Abstract\]](#) [\[PDF Full-Text \(320KB\)\]](#) **IEEE JNL**

2 A scheme for controlled islanding to prevent subsequent blackout
Ahmed, S.S.; Sarker, N.C.; Khairuddin, A.B.; Ghani, M.R.B.A.; Ahmad, H.
Power Systems, IEEE Transactions on , Volume: 18 , Issue: 1 , Feb. 2003
Pages:136 - 143

[\[Abstract\]](#) [\[PDF Full-Text \(552KB\)\]](#) **IEEE JNL**

3 Potential benefits of using distributed parameter model for transmission lines in power system analysis
Ahmed, S.S.; Rajaratnam, M.; Ahmad, H.; Sidik, M.A.B.
Power Engineering Review, IEEE , Volume: 22 , Issue: 10 , Oct. 2002
Pages:53 - 56

[\[Abstract\]](#) [\[PDF Full-Text \(376KB\)\]](#) **IEEE JNL**

4 Design of suboptimal H^∞ excitation controllers
Ahmed, S.S.; Chen, L.; Petroianu, A.
Power Systems, IEEE Transactions on , Volume: 11 , Issue: 1 , Feb. 1996
Pages:312 - 318

[\[Abstract\]](#) [\[PDF Full-Text \(680KB\)\]](#) **IEEE JNL**

5 A new method of excitation control based on fuzzy set theory
Handschin, E.; Hoffmann, W.; Reyer, F.; Stephanblome, T.; Schlucking, U.; Westermann, D.; Ahmed, S.S.
Power Systems, IEEE Transactions on , Volume: 9 , Issue: 1 , Feb. 1994
Pages:533 - 539

[\[Abstract\]](#) [\[PDF Full-Text \(552KB\)\]](#) **IEEE JNL**

6 Single carrier PWM scheme for cascaded multilevel voltage source inverter
Salam, Z.; Aziz, J.; Ahmed, S.S.;
Power Electronics and Drive Systems, 2003. PEDS 2003. The Fifth International Conference on ,Volume: 1 , 17-20 Nov. 2003
Pages:406 - 410

[\[Abstract\]](#) [\[PDF Full-Text \(526KB\)\]](#) [IEEE CNF](#)

7 A planner 6.3 nm thin-body SOI MOSFET using tunnel epitaxy and nitrided gate oxides
Ahmed, S.S.; Neudeck, G.W.; Denton, J.P.; Stidham, M.E.;
University/Government/Industry Microelectronics Symposium, 2003. Proceed of the 15th Biennial , 30 June-2 July 2003
Pages:280 - 283

[\[Abstract\]](#) [\[PDF Full-Text \(342KB\)\]](#) [IEEE CNF](#)

8 Assessing how safe are the rural tin-shed houses in the vicinity of E fields of the cross-country power lines
Ahmed, S.S.; Haque, R.;
Electromagnetic Compatibility Proceedings, 1997 International Symposium on 23 May 1997
Pages:401 - 404

[\[Abstract\]](#) [\[PDF Full-Text \(320KB\)\]](#) [IEEE CNF](#)

9 A high performance 0.25 μ m logic technology optimized for 1.8 V operation
Bohr, M.; Ahmed, S.S.; Ahmed, S.U.; Bost, M.; Ghani, T.; Greason, J.; Hains R.; Jan, C.; Packan, P.; Sivakumar, S.; Thompson, S.; Tsai, J.; Yang, S.;
Electron Devices Meeting, 1996., International , 8-11 Dec. 1996
Pages:847 - 850

[\[Abstract\]](#) [\[PDF Full-Text \(348KB\)\]](#) [IEEE CNF](#)

10 Narrow-width SOI devices the role of quantum mechanical space-quantization effects on device performance
Ahmed, S.S.; Vasileska, D.;
Nanotechnology, 2002. IEEE-NANO 2002. Proceedings of the 2002 2nd IEEE Conference on , 26-28 Aug. 2002
Pages:243 - 246

[\[Abstract\]](#) [\[PDF Full-Text \(358KB\)\]](#) [IEEE CNF](#)

11 Nitrided thermal SiO_2 for thin buried gate insulators in dual gate Si MOSFET
Ahmed, S.S.; Su, T.; Denton, J.P.; Neudeck, G.W.;
University/Government/Industry Microelectronics Symposium, 1999. Proceed of the Thirteenth Biennial , 20-23 June 1999
Pages:43 - 46

[Abstract] [PDF Full-Text (332KB)] IEEE CNF

12 Design of suboptimal H_∞ excitation controllers

Ahmed, S.S.; Chen, L.; Petrojanu, A.;

Power Industry Computer Application Conference, 1995. Conference Proceedings
1995 IEEE , 7-12 May 1995

Pages: 199 - 205

[Abstract] [PDF Full-Text (604KB)] **IEEE CNF**

13 Power system security control using a neural network trained by f termination of an iterative scheme

Ahmed, S.S.;

Industrial Automation and Control, 1995 (I A & C'95), IEEE/IAS International Conference on (Cat. No.95TH8005) - 5-7 Jan. 1995

Pages:317 - 322

[Abstract] [PDF Full-Text (464KB)] [IEEE CNF](#)

14 A new method of excitation control based on fuzzy set theory

Handschin, E.; Hoffmann, W.; Reyer, F.; Stephanblome, T.; Schlucking, U.; Westermann, D.; Ahmed, S.S.:

Power Industry Computer Application Conference, 1993. Conference Proceedings - 4-7 May 1993

Pages: 34 - 40

[Abstract] [PDF Full-Text (552KB)] [IEEE CNF](#)

15 **Wireless power transmission and its annexure to the grid system**

Ahmed, S.S.; Yeong, T.W.; Ahmad, H.B.;

Generation, Transmission and Distribution, IEE Proceedings- ,Volume: 150 ,
2 . March 2003

Pages: 195 - 199

[Abstract] [PDF Full-Text (417KB)] [\[TEI\]](#) [\[NL\]](#)

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